

54AC11174, 74AC11174 HEX D-TYPE FLIP-FLOPS WITH CLEAR

TI0140—D3434, MARCH 1990

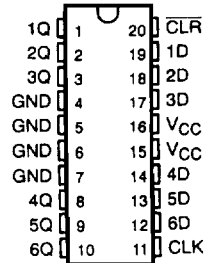
- Applications Include: Buffer/Storage Registers, Shift Registers, Pattern Generators
- Flow-Through Architecture to Optimize PCB Layout
- Center-Pin V_{CC} and GND Configurations to Minimize High-Speed Switching Noise
- EPIC™ (Enhanced-Performance Implanted CMOS) 1- μ m Process
- 500-mA Typical Latch-Up Immunity at 125°C
- Package Options Include Plastic "Small Outline" Packages, Ceramic Chip Carriers, and Standard Plastic and Ceramic 300-mil DIPs

description

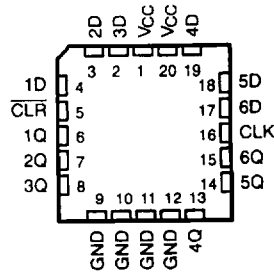
These positive-edge-triggered flip-flops implement D-type flip-flop logic with a direct clear input. Information at the D inputs meeting the setup time requirements is transferred to the outputs on the positive-going edge of the clock pulse. Clock triggering occurs at a particular voltage level and is not directly related to the transition time of the positive-going pulse. When the clock input is at either the high or low level, the D input signal has no effect at the output.

The 54AC11174 is characterized for operation over the full military temperature range of -55°C to 125°C. The 74AC11174 is characterized for operation from -40°C to 85°C.

54AC11174 ... J PACKAGE
74AC11174 ... DW OR N PACKAGE
(TOP VIEW)



54AC11174 ... FK PACKAGE
(TOP VIEW)



FUNCTION TABLE
(each flip-flop)

INPUTS			OUTPUT
CLR	CLK	D	Q
L	X	X	L
H	↑	H	H
H	↑	L	L
H	L	X	Q ₀

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TEXAS
INSTRUMENTS

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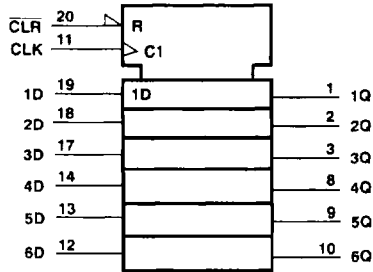
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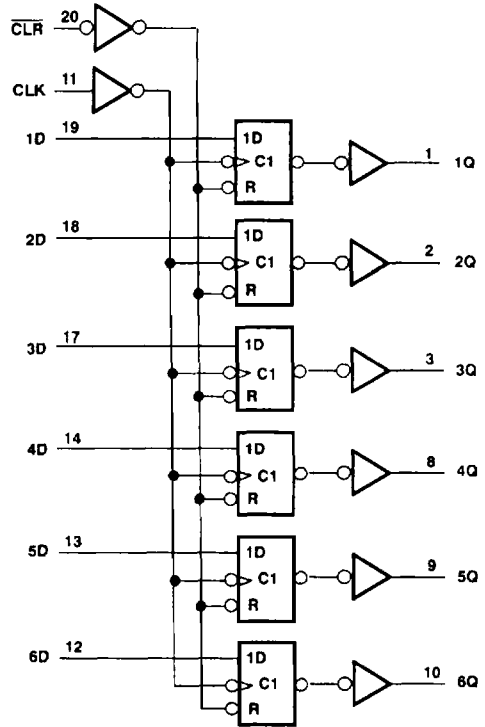
D3434, MARCH 1990—T10140

logic symbol†



† This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.
Pin numbers shown are for DW, J, or N packages.

logic diagram (positive logic)



Pin numbers shown are for DW, J, or N packages.

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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)[†]

Supply voltage range, V_{CC}	-0.5 V to 7 V
Input voltage range, V_I (see Note 1)	-0.5 V to $V_{CC} + 0.5$ V
Output voltage range, V_O (see Note 1)	-0.5 V to $V_{CC} + 0.5$ V
Input clamp current, I_{IK} ($V_I < 0$ or $V_I > V_{CC}$)	± 20 mA
Output clamp current, I_{OK} ($V_O < 0$ or $V_O > V_{CC}$)	± 50 mA
Continuous output current, I_O ($V_O = 0$ to V_{CC})	± 50 mA
Continuous current through V_{CC} or GND pins	± 150 mA
Storage temperature range	-65°C to 150°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

recommended operating conditions

		54AC11174			74AC11174			UNIT
		MIN	NOM	MAX	MIN	NOM	MAX	
V_{CC}	Supply voltage	3	5	5.5	3	5	5.5	V
V_{IH}	High-level input voltage	$V_{CC} = 3$ V		2.1	$V_{CC} = 3$ V		2.1	V
		$V_{CC} = 4.5$ V		3.15	$V_{CC} = 4.5$ V		3.15	
		$V_{CC} = 5.5$ V		3.85	$V_{CC} = 5.5$ V		3.85	
V_{IL}	Low-level input voltage	$V_{CC} = 3$ V			$V_{CC} = 3$ V		0.9	V
		$V_{CC} = 4.5$ V			$V_{CC} = 4.5$ V		1.35	
		$V_{CC} = 5.5$ V			$V_{CC} = 5.5$ V		1.65	
V_I	Input voltage	0		V_{CC}	0		V_{CC}	V
V_O	Output voltage	0		V_{CC}	0		V_{CC}	V
I_{OH}	High-level output current	$V_{CC} = 3$ V			$V_{CC} = 3$ V		-4	mA
		$V_{CC} = 4.5$ V			$V_{CC} = 4.5$ V		-24	
		$V_{CC} = 5.5$ V			$V_{CC} = 5.5$ V		24	
I_{OL}	Low-level output current	$V_{CC} = 3$ V			$V_{CC} = 3$ V		12	mA
		$V_{CC} = 4.5$ V			$V_{CC} = 4.5$ V		24	
		$V_{CC} = 5.5$ V			$V_{CC} = 5.5$ V		24	
$\Delta t/\Delta v$	Input transition rise or fall rate	0		10	0		10	ns/V
T_A	Operating free-air temperature	-55		125	-40		85	°C

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**54AC11174, 74AC11174
HEX D-TYPE FLIP-FLOPS WITH CLEAR**

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electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	V _{CC}	T _A = 25°C			54AC11174		74AC11174		UNIT
			MIN	TYP	MAX	MIN	MAX	MIN	MAX	
V _{OH}	I _{OH} = 50 μA	3 V	2.9			2.9		2.9	V	
		4.5 V	4.4			4.4		4.4		
		5.5 V	5.4			5.4		5.4		
	I _{OH} = 4 mA	3 V	2.58			2.4		2.48		
		4.5 V	3.94			3.7		3.8		
	I _{OH} = -24 mA	4.5 V	4.94			4.7		4.8		
		5.5 V				3.85				
V _{OL}	I _{OL} = 50 μA	3 V			0.1		0.1	0.1	V	
		4.5 V			0.1		0.1	0.1		
		5.5 V			0.1		0.1	0.1		
	I _{OL} = 12 mA	3 V			0.36		0.5	0.44		
		4.5 V			0.36		0.5	0.44		
	I _{OL} = 24 mA	4.5 V			0.36		0.5	0.44		
		5.5 V			0.36		0.5	0.44		
I _{OL} = 50 mA†	5.5 V					1.65				
	5.5 V						1.65			
I _I	V _I = V _{CC} or GND	5.5 V			+0.1		±1	±1	μA	
I _{CC}	V _I = V _{CC} or GND, I _O = 0	5.5 V			8		160	80	μA	
C _i	V _I = V _{CC} or GND	5 V			4				pF	

† Not more than one output should be tested at a time, and the duration of the test should not exceed 10 ms.

operating characteristics, V_{CC} = 5 V, T_A = 25°C

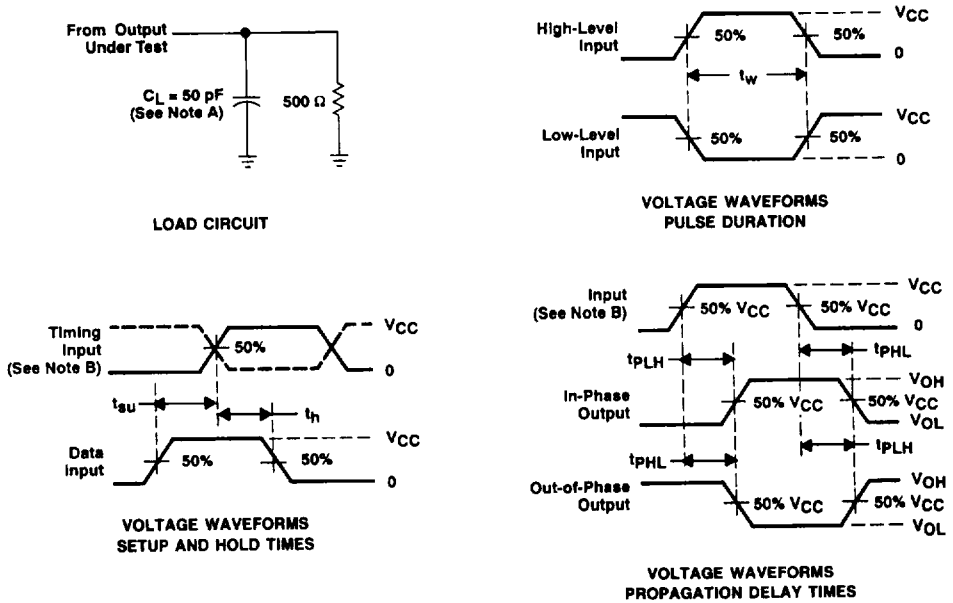
PARAMETER	TEST CONDITIONS	TYP	UNIT
C _{pd} Power dissipation capacitance	Outputs enabled	35	pF

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PARAMETER MEASUREMENT INFORMATION



- NOTES: A. C_L includes probe and jig capacitance.
 B. Input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, $Z_o = 50 \Omega$, $t_r = 3$ ns, $t_f = 3$ ns. For testing t_{max} and pulse duration: $t_r = 1$ to 3 ns, $t_f = 1$ to 3 ns.
 C. The outputs are measured one at a time with one input transition per measurement.

FIGURE 1. LOAD CIRCUIT AND VOLTAGE WAVEFORMS

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